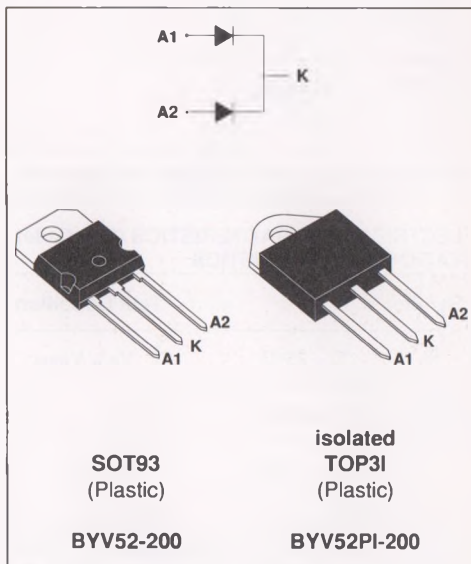# HIGH EFFICIENCY FAST RECOVERY RECTIFIER DIODES

FEATURES

- SUITED FOR SMPS
- VERY LOW FORWARD LOSSES
- NEGLIGIBLE SWITCHING LOSSES
- HIGH SURGE CURRENT CAPABILITY
- HIGH AVALANCHE ENERGY CAPABILITY
- INSULATED VERSION TOP3I :
  Insulating voltage = 2500 V DC
  Capacitance = 12 pF

isolated

SOT93	TOP3I
(Plastic)	(Plastic)
BYV52-200	BYV52PI-200

DESCRIPTION

Dual center tap rectifier suited for switchmode power supply and high frequency DC to DC converters.
Packaged in SOT93, or TOP3I this device is intended for use in low voltage, high frequency inverters, free wheeling and polarity protection applications.

ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter				Value	Unit
$I_{F(RMS)}$	RMS forward current			Per diode	50	A
$I_{F(AV)}$ $\delta = 0.5$	Average forward current	SOT93	Tc=110°C	Per diode	30	A
		TOP3I	Tc=90°C	Per diode	30	
I_{FSM}	Surge non repetitive forward current		tp=10ms sinusoidal	Per diode	500	A
Tstg Tj	Storage and junction temperature range				- 40 to + 150 - 40 to + 150	°C °C

Symbol	Parameter	BYV52-/PI-				Unit
		50	100	150	200	
V_{RRM}	Repetitive peak reverse voltage	50	100	150	200	V

THERMAL RESISTANCE

Symbol	Parameter			Value	Unit
Rth (j-c)	Junction to case	SOT93	Per diode	1.2	°C/W
			Total	0.75	
		TOP3I	Per diode	1.8	
			Total	1.2	
Rth (c)	Coupling	SOT93		0.3	°C/W
		TOP3I		0.6	

When the diodes 1 and 2 are used simultaneously :
Tj-Tc (diode 1) = P(diode 1) x Rth(j-c)(Per diode) + P(diode 2) x Rth(c)

ELECTRICAL CHARACTERISTICS (Per diode)
STATIC CHARACTERISTICS

Symbol	Test Conditions		Min.	Typ.	Max.	Unit
I_R *	$T_j = 25°C$	$V_R = V_{RRM}$			25	μA
	$T_j = 100°C$				2.5	mA
V_F **	$T_j = 125°C$	$I_F = 20$ A			0.85	V
	$T_j = 125°C$	$I_F = 40$ A			1.00	
	$T_j = 25°C$	$I_F = 40$ A			1.15	

Pulse test : * tp = 5 ms, duty cycle < 2 %
       ** tp = 380 μs, duty cycle < 2 %

To evaluate the conduction losses use the following equation :
$P = 0.7 \times I_{F(AV)} + 0.0075 \times I_F^2{}_{(RMS)}$

RECOVERY CHARACTERISTICS

Symbol	Test Conditions		Min.	Typ.	Max.	Unit
trr	$T_j = 25°C$	$I_F = 0.5A$ $I_{rr} = 0.25A$ $I_R = 1A$			35	ns
		$I_F = 1A$ $dI_F/dt = -50A/μs$ $V_R = 30V$			50	
tfr	$T_j = 25°C$	$I_F = 1A$ $tr = 5$ ns $V_{FR} = 1.1 \times V_F$		10		ns
V_{FP}	$T_j = 25°C$	$I_F = 1A$ $tr = 5$ ns		1.5		V

Fig.1 : Average forward power dissipation versus average forward current.
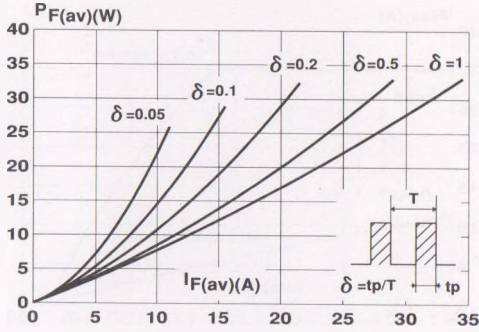

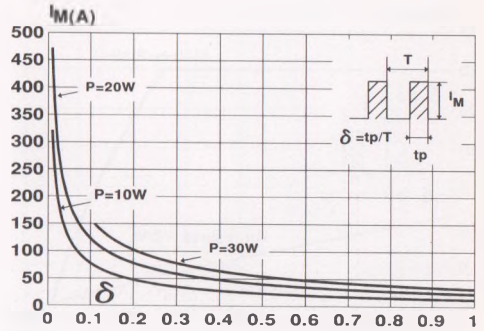**Fig.2** : Peak current versus form factor.

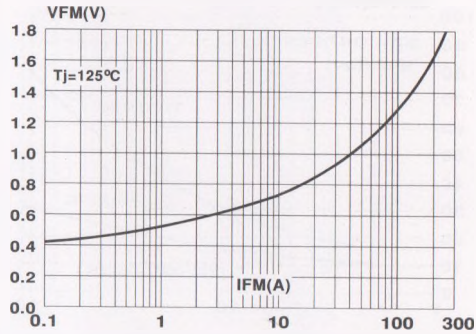**Fig.3** : Forward voltage drop versus forward current (maximum values).

Fig.4 : Relative variation of thermal impedance junction to case versus pulse duration.
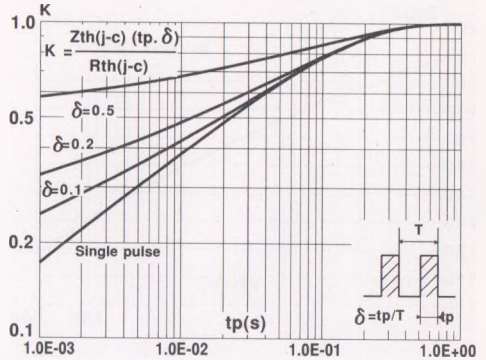

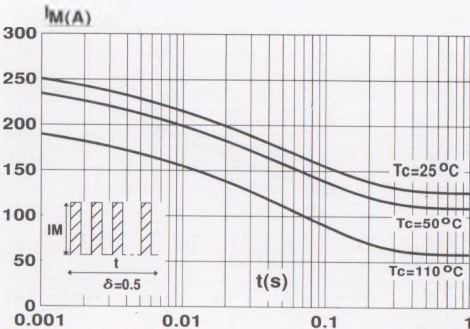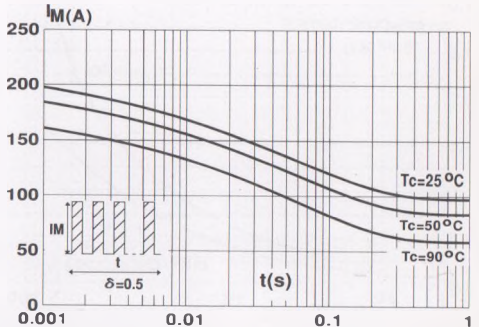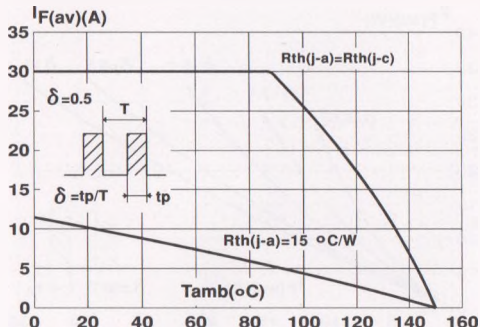**Fig.5** : Non repetitive surge peak forward current versus overload duration. (SOD93)

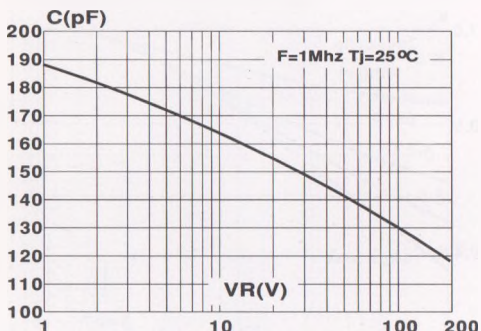**Fig.6** : Non repetitive surge peak forward current versus overload duration. (TOP3I)

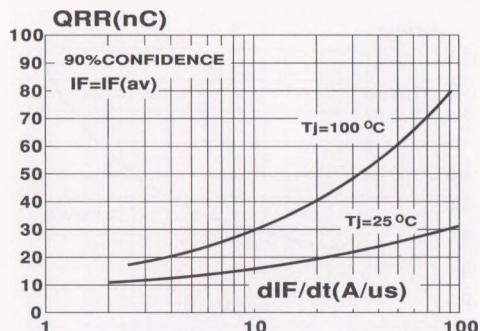Fig.7 : Average current versus ambient temperature.
(duty cycle : 0.5) (SOD93)

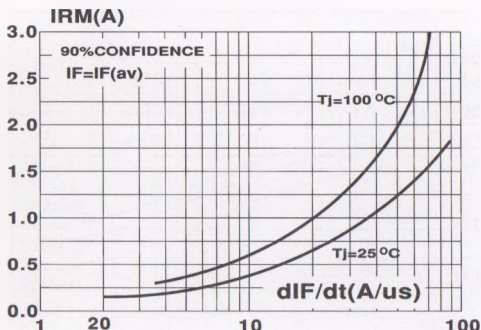Fig.8 : Average current versus ambient temperature.
(duty cycle : 0.5) (TOP3I)

Fig.9 : Junction capacitance versus reverse voltage applied (Typical values).

Fig.10 : Recovery charges versus dI_F/dt.

Fig.11 : Peak reverse current versus dIF/dt.

Fig.12 : Dynamic parameters versus junction temperature.

SGS-THOMSON
MICROELECTRONICS